SGS Fimko Ltd.

TEST REPORT IEC 60947-7-2

Low-voltage switchgear and controlgear Part 7: Ancillary equipment

Section Two: Protective terminal blocks for copper conductors

Report Number.....: HELES2311001096-1

Date of issue: 2024.01.24

Total number of pages 11

Name of Testing Laboratory SGS Fimko Ltd.

preparing the Report:

Applicant's name: Ouneva Oy

Address.....: Teollisuustie 21, 82730 TUUPOVAARA, FINLAND

Test specification:

Standard: IEC 60947-7-2:2009 (Third Edition) in conjunction with IEC

60947-1 (Fifth Edition) + A1:2012 + A2:2014

Test procedure: Investigation

Non-standard test method: N/A

Test Report Form No.: IEC60947_7_2B

Test Report Form(s) Originator....: DEKRA Certification B.V.

Master TRF: Dated 2016-01

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Test item description:	: Connector for power cables		
Trade Mark:	OUNEVA		
Manufacturer:	Ouneva Oy		
Model/Type reference:	VA05-0004, VA05-0005, VA05-0006, VA05-0007		
Ratings::	35-50 mm², 50-70 mm²,	95-120 mm², 70-95 mm²	
Responsible Testing Laboratory (as applicate	ole), testing procedure	and testing location(s):	
	SGS Fimko Ltd.		
Testing location/ address:	Takomotie 8 FI-00380 Helsinki Finland		
☐ Associated CB Testing Laboratory:			
Testing location/ address:			
Tested by (name, function, signature):	Juhani Raitio	Intimo Deter	
	Project Manager	7.44m (P.44)	
Approved by (name, function, signature):	Vesa Haapaoja	Win Detail	
	Testing Engineer	/	
Testing procedure: CTF Stage 1:	N/A		
Testing location/ address:			
Tested by (name, function, signature):			
Approved by (name, function, signature):			
Testing procedure: CTF Stage 2:	N/A		
Testing location/ address:			
Tested by (name + signature):			
Witnessed by (name, function, signature) .:			
Approved by (name, function, signature):			
Testing procedure: CTF Stage 3:	N/A		
Testing procedure: CTF Stage 4:	N/A		
Testing location/ address:			
Tested by (name, function, signature):			
Witnessed by (name, function, signature) .:			
Approved by (name, function, signature):			
Supervised by (name, function, signature)::			
supervised by (name, function, signature):			





List of Attachments (including a total number of pages in each attachment):

_

Summary of testing:

All applicable clauses.

Tests performed (name of test and test clause):

,

3 short circuit tests were done according to EN 60947-7-2.

Testing location:

SGS CBTL (See page 2)

Summary of compliance with National Differences (List of countries addressed):

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☐ The product fulfils the requirements of EN 60947-7-1:2009 and EN 60947-7-2:2009.

Copy of marking plate:







Test item particulars:	
Particulars: test item vs. test requirements	
- method of fixing crimped	
- number of poles 1	
- type of clamping unit see page 6	
- ability to receive conductors 2	
- number of terminals on terminal assembly 1	
- rated cross-section (mm²) see page 6	
- rated connecting capacity (mm²): see page 6	
Possible test case verdicts:	
- test case does not apply to the test object: N/A	
- test object does meet the requirement: P (Pass)	
- test object does not meet the requirement: F (Fail)	
Testing:	
Date of receipt of test item 2023.12.17	
Date (s) of performance of tests 2023.12.17 – 2023.01.	19
General remarks:	
"(See Enclosure #)" refers to additional information appended to the report. "(See appended table)" refers to a table appended to the report.	
Throughout this report a \boxtimes comma / \square point is used as the decimal se	parator.
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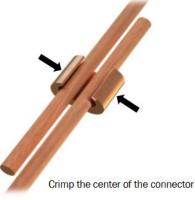
General product information:

Description

C-sleeves are designed for connecting, branching and extending of copper lines. Sleeves are manufactured of 99,9% pure copper. C-sleeves are marked with manufacturer symbol, sleeve type and the sizes of compatible wires

Crimping







Product / Crimping information					
Product code	Product name	Main conductor	Branch conductor	Elpress	
I roduct code				Crimping dies	No. of crimps
VA05-0004	C-connector C9	35-50 mm ²	35-50 mm ²	BC8-9	1
VA05-0005	C-connector C11	50-70 mm ²	50-70 mm ²	BC11	1
VA05-0006	C-connector C15	95-120 mm²	95-120 mm²	BC15 / 13BC15*	1/3*
VA05-0007	C-connector C13	70-95 mm ²	70-95 mm ²	BC13 / 13BC13*	1/3*





	IEC 60947-7-2		
Clause	Requirement – Test	Result - Remark	Verdict
8.4.6	Short-time withstand current test		
	- cross-section of the conductor (mm²):	C9 - 50 mm ²	_
		C11 - 70 mm ²	
		C13 - 95 mm ²	
		C15 - 120 mm ²	
	Test current from clamping unit to clamping unit (1	-1)	
	- test current (A):	Tested values:	_
		C9 – 8,4 / 8,3 / 8,3 kA	
		C11 – 8,6 / 8,7 / 8,7 kA	
		C13 – 11,5 / 11,5 / 11,7 kA	
		C15 – 14,8 / 14,7 / 14,8 kA	
		Requirements:	
		C9 – 6 kA	
		C11 – 8,4 kA	
		C13 – 11,4 kA	
		C15 – 14,4 kA	
	- duration of the test current (s):	1 s.	_
	At the end of the test, continuity shall exist on the		Р
	test sample assembly and the terminal blocks		
	shall not show any cracking, breakage or other		
	critical damage		
	Voltage drop after short-time withstand current tes	t	Р

- cross-section of the conductor (mm²) : C9 - 50 mm²

C11 - 70 mm² C13 - 95 mm² C15 - 120 mm²





	IEC 60947-7-2	_	
Clause	Requirement – Test	Result - Remark	Verdict
	- test current (A) d.c.	C9 – 15 A	_
		C11 – 19,2 A	
		C13 – 23,2 A	
		C15 – 26,9 A	
	- voltage drop (mV) before short-time withstand	C9 – 0,19 mV	Р
	current test not exceeding 3,2 mV:	C11 – 0,25 mV	
		C13 – 0,40 mV	
		C15 – 0,24 mV	
	- voltage drop (mV) after short-time withstand	C9 – 0,20 mV	Р
	current test not exceeding 3,2 mV:	C11 – 0,27 mV	
		C13 – 0,44 mV	
		C15 – 0,26 mV	
	If the measured value exceeds 3,2 mV, the voltage		N/A
	drop is determined on each individual clamping		
	unit separately, which shall not exceed 1,6 mV		





List of test equipment used:

Clause	Measurement / testing	Testing / measuring equipment / material used, (Equipment ID)	Range used	Last Calibration date	Calibration due date
8.4.6	Short-time withstand current	Datalogger, Inv. No 8662	0 – 200 °C	30.1.2023	30.1.2024
	Short-time withstand current	Oscilloscoop, Lecroy, Inv. No 11444	GJ	23.3.2023	23.3.2024
	Voltage	Digital Multimeter, Fluke 177, Inv. No 7298	0 - 400 V	26.9.2023	26.9.2024
	Current	Clamp meter, Kyoritsu 2009, Inv. No 4997	0 - 1500 A	24.2.2023	24.2.2024
	Length	Digital Caliper, Inv. No 5103	0 - 150 mm	28.9.2023	28.9.2024























